Performance tests of the ATLAS Inner Tracker Pixel detector opto-electrical conversion system

Marianna Glazewska

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Following on from Lucas' talk...

- Crucial period for verification of data transmission and mechanical performance of Optosystem
- Mechanic:
 - Optopanel fibre bundle fitting, mounting
- Data transmission:
 - Optoboard performance under intense radiation
 - Optoboard testing for Optosystem construction ("production")



Mechanics of the Optosystem



Twinax fitting

- What was done?
 - 1. Electrical signal cables (twinax) attached to 3D printed "termination boards" that fit onto Optoboxes
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- Solutions:
 - 1. Small R side of panel redesigned to make entry wider
 - Real termination boards are stiffer (D) but curling should still be something to keep in mind when filling panel





Mounting at CERN

• Aim: start to devise a plan of how to install the Optosystem in the ATLAS cavern



Inner services mock-up, B180@CERN

Proposal:

- 1. Attach adapter plate to endplate and cover screws with kapton tape
- Mount Optopanel onto adapter plate without Optoboxes (manouvre ~30 kg instead of 60 kg)
- 3. Fill Optopanel with Optoboxes from small-R to large-R

Mounted Optopanel



Mounted adapter plate





Optopanel with Optoboxes removed









The Optoboard





• Around 1600 of these boards will read out the full ITk pixel detector

• GBCR

GigaBit Cable Receiver used for signal recovery and equalisation

• IpGBT

Low Power GigaBit Transceiver used for serialisation

• VTRx+

Versatile Link Plus Transceiver used for opto-electrical conversion







Data transmission chain





Optoboard irradiation

- At Inselspital Bern cyclotron
 - Irradiations by day, radiopharmaceutical production by night
- Expected dose (10 years): 50 kGy (see plot), we irradiate to: 150 kGy* (40 mins, safety factor=3)
- Optoboard connected with an ITk Pixel module via adapter boards





Irradiated components

lpGBT	GBCR	VTRx+
 Bit Error Ratio Test	 Bit Error Ratio Test	 Bit Error Ratio Test
(BERT) with PRBS7 Single Event Upset	(BERT) with PRBS7 Single Event Upset	(BERT) with Aurora
(SEU) counter	(SEU) counter	64/66b



IpGBT/GBCR: BERT with PRBS7 **VTRx+**: Soft Error (BERT) with Aurora

Bit Error Ratio

- Tests data transmission quality
- BER limit = 95% confidence interval
 - Industry standard is limit of O(10⁻¹²)



- $\lim_{\substack{\text{BER} \\ 95\%(x) = \\ 1.28 \cdot 10^9 \cdot \text{efficiency} \cdot t}} P^+(x) & \text{where:} \\ P_+ Poisson upper limit for x errors} \\ P_+ Poisson upper limit for x errors \\ T_- measurement time \\ P_+ Poisson upper limit for x errors \\ P_+ Poisson$
- Two protocols used:
 - PRBS7: known pattern, 100% efficiency, tests quality between front-end and lpGBT
 - Aurora 64/66b: emulates real datastream, 62% efficiency, tests quality between front-end and FELIX



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Single Event Upsets (SEUs)

- Does not cause permanent damage
- Caused by radiation: ionising particle causes bit flip in datastream
- Monitored by IpGBT
- How are SEUs recorded in our case?
 - IpGBT registers are triplicated and compared





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 Not done for N
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- How are SEUs recorded in our case?
 - IpGBT registers are triplicated and compared
 - Any mismatch results in the recording of an SEU
 - The incorrect register copy is corrected



ITk Pixe 0 0 1 0 0 +1 SEU 13

Not done for VTRx+: Optoboard too thick to let particles from beam through to lpGBT!

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- Measurement time = 54 s
- $\lim(BER)_{95\%}(0) = 4.34 \cdot 10^{-11}$

IpGBT 1 irradiation

Fluctuations in BER limit:

 Instantaneous flux is many times higher than what is expected – probability of bit error occuring is significantly higher

Drops in dose:

- Feature of cyclotron source
- Does not affect results in any way



-- BERT 95% CL upper limit for 0 errors



GBCR 1 irradiation



Measurement time = 54 s

 $\lim(BER)_{95\%}(0) = 4.34 \cdot 10^{-11}$

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VTRx+ irradiation

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Note: Pre-irradiation plot is not for the irradiated board, but still v4

Soft error scan pre- and post-irradiation

- Signs of damage: •
 - Compromised data transmission where not expected (black) ٠
 - Region of zero errors slightly 'shrinks' after irradiation (green) •



Test for Optoboard production

• Aim: design a quick and efficient way of testing Optoboards

6DP to ERF board

PCB designed specifically for Optoboard testing, and can access all uplinks and 6/8 downlinks





Optoboard test setup (prototype)

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Small ITk Pixel module

Final version sensor chip on a PCB with dedicated ports for data transmission (DP) and powering (LV and HV)





Upcoming improvements

- Current setup does not allow for all downlinks and uplinks to be tested simultaneously (2 downlinks not tested)
 - Proposed solution: reorganise 6DP board into 8DP board with 3 uplinks per port



 Difficulty connecting optical fibre ferrules without risk of damaging VTRx+ fibre





Optoboard test setup (prototype)

Summary

The time has come to build the Optosystem!

- Established initial Optopanel filling (Optoboxes and twinax) and mounting procedures
 - Next steps: Finish mechanical tests of Optopanel, including optical fibre fitting
- Optoboard v4 (final) passed irradiation test even with a safety factor of 3!
 - Next steps: None
- Preparation of Optosystem component test setups including Optoboard test (others not mentioned: cables (CAN, power,...), fibres, Powerboard, Connectorboard, ...)
 - Next steps: Finalise all tests before we start to receive components, then TEST THEM ALL!



Thank you! marianna.glazewska@unibe.ch

Bern Optosystem presentations

Previous talk: Tests and results of the power components of the ATLAS Inner Tracker detector readout system (L. Mollier)

Next talk: Time-domain Reflectometer Measurements of the Optosystem Data Transmission Chain (U. Alberti)



Optoboard data transmission

FOR FUNDAMENTAL PHYSIC



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How to calculate P⁺

- Bit errors are all independent \rightarrow Binomial distribution is suitable!
- HOWEVER: p << n → Poisson approximation!

Number of bits checked

Probability that bit is wrong

$$\sum_{r=0}^{N_{\text{err}}} P(r, N_{+}) = 1 - 0.95, \qquad P(r, N_{+}) = \frac{e^{-N_{+}} \cdot (N_{+})^{r}}{r!} \qquad BER_{95\%} = \frac{N_{+}}{N_{bits}}.$$

• Above 10 bit errors, BER limit calculated using:

$$BER_{95\%} \approx \frac{N_{err} + 1.96\sqrt{N_{err}}}{N_{bits}}$$

$$\frac{u^{b}}{\sum_{v \in V} \sum_{v \in V} \sum_{$$

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Soft Errors (BERT)

- Tests data transmission between front-end and FELIX
- Also BERT, but following 64/66b Aurora protocol
 - 64 bits of datastream scrambled into 66 bits (64 + 2 bit header)



- Scrambling/unscrambling depends on three bits (ith,(i-38)th,(i-57)th)
 - After taking into account double counting, 62% of datastream covered



Inselspital cylotron

- Cyclotron facility split into two bunkers: cyclotron and irradiation
- Bunkers separated by thick wall, and beam transer line passes through this wall
 - Safe to be inside irradiation bunker when cyclotron running and beam shutter is closed

 $u^{\scriptscriptstyle b}$



Inselspital cyclotron irradiation bunker

End of beam transfer line Comes from cyclotron bunker –



2D stage At this point protons have 16.7 MeV energy

Quadrupole doublet Used for beam focusing

Beam viewer

For beam current measurements, which are used







Collimator Used 1x1 cm² as largest ASIC is 0.9x0.9 cm²

Cyclotron proton beam energy



Calculating dose



- Current (I) is known (files provided by Isidre Mateu)
- Stopping power (dE/dx) calculated using electron charge (e) and energy of 16.7 MeV
- Beam area (A_{beam}) calculated assuming beam is circular with 1.5 cm radius, and removing collimator area (1 cm²) – this is area hitting collimator



Aligning Optoboard with beam



- Using photochromic film, one can see where the beam hit the Optoboard
 - Size of spot should be the same as size of collimator used



• Measurement time = 54 s

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$$\lim(BER)_{95\%}(0) = 4.34 \cdot 10^{-11}$$

IpGBT 3 irradiation

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GBCR 3 irradiation

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